

Constrained sintering process for LTCC Fodel[®] Process

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Fodel Process & Constrained Sintering for LTCC



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DuPont *i* Technologies

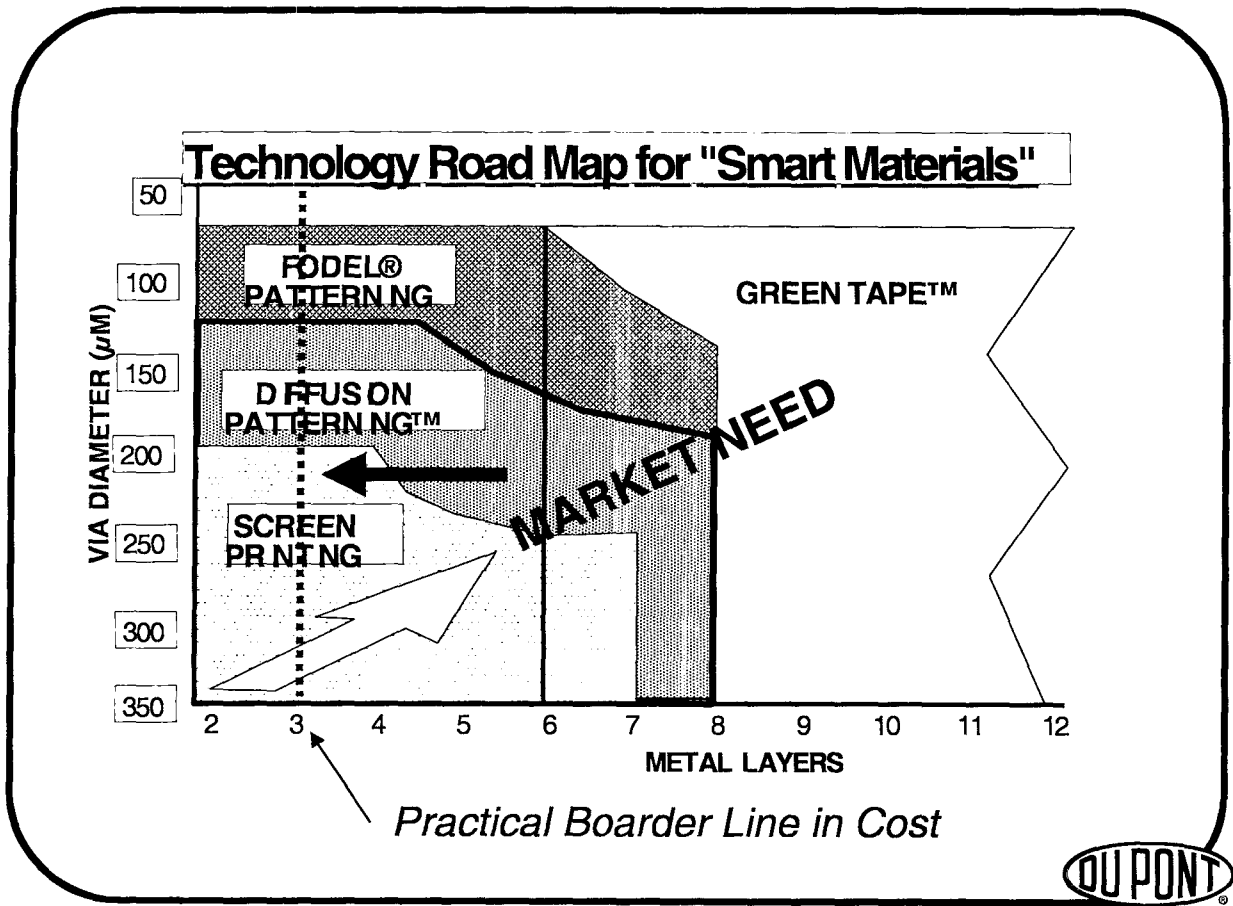
Sep 2nd ,2000
IMAPS KOREA



Market Status (LTCC / Fodel Related) in Japan

- ◆ **Booming in use of Hi-Density Multilayer Boards in IC Pkg. /CPU/Consumer Area**
- Build-Up PWB / ALIVH are leading technology.
- ◆ **Increasing requirements for Finer pitch (< 85 μ m pitch)**
and/or Flip chip assembling on to board.
- ◆ **BGA connection become more popular and BGA connection cracking become industry's issue.**
- ◆ **Emerging MCM's on Build-Up PWB in Consumer Area**
- Pentium II / Note PC CPU / Casio Radio / TV Phone Camera
- ◆ **LTCC in Automotive application become real finally both in Japan and Europe.**
European Automotive will deeply link with Japanese LTCC makers/Module makers.
- ◆ **Be unaware of LTCC technology in the industry especially circuit designers**
- Recognized HTCC only as ceramic technology and Alumina is recognized for traditional hybrid only.
- ◆ **Fodel® on constrain sintered LTCC with buried R technology can compete with Build-Up PWB.**
- < 85 μ m pitch top patterning // < 100 μ m via ϕ // < 10 μ m/10mm coplanarity // Buried R



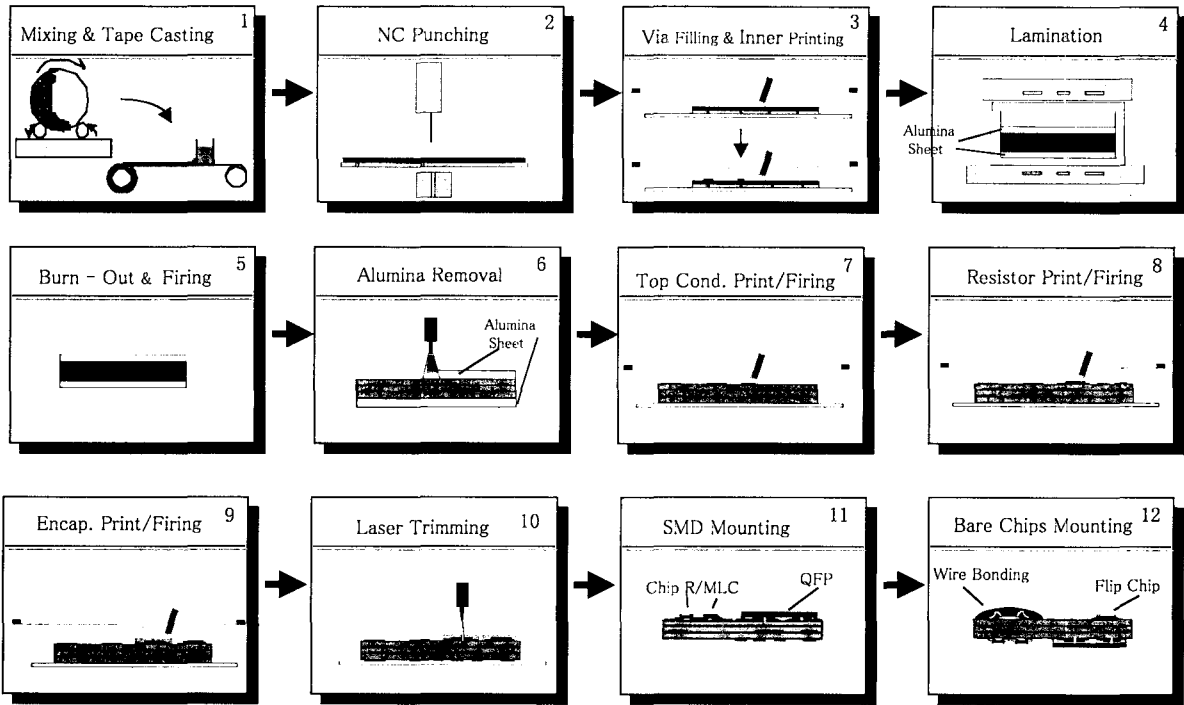


LTCC Process Comparison

	Free Sintering		Constrain Sintering (Zero XY Shrinkage)	
	Post-Fire	Co-Fire	PLAS Pressure Assisted Sintering Fire without Pressure	PAS Pressure Assisted Sintering Fire with Pressure
Process characteristic	Fire top conductor after fired LTCC substrate Standard Firing for LTCC	Co-fire top conductor with LTCC substrate Minimize misalignment of top conductors/via pads on via locations since co-firing between top and LTCC. Best for LTCC with cavity structure	Fire LTCC parts sandwiched with green alumina tapes after lamination.	Fire LTCC parts with pressure in addition to PLAS process. Expensive for special firing equipment.
PAT Situation on Process			Du Pont hold PAT in US, Europe/Japan and license several customers	Du Pont hold PAT in US, Europe/Japan and license several customers
Fired LTCC characteristic			• Can make Hi-density LTCC • Can make thin and flat LTCC	• Can make Hi-density LTCC • Can make thin and flat LTCC
Fired LTCC feature			Increase # of parts from one substrate and higher yield with less misalignment due to zero XY-shrinkage give lower cost. No influence from lot variation in tape shrinkage.	Increase # of parts from one substrate and higher yield with less misalignment due to zero XY-shrinkage give lower cost. No influence from lot variation in tape shrinkage.
XY shrinkage(Green->Fired)	13~16% ± 0.5%	13~16% ± 0.5%	0.1% ± 0.05 %	0.1% ± 0.05 %
Z shrinkage(Green->Fired)	20~30% ± 0.5%	20~30% ± 0.5%	45~50% ± 0.5%	45~50% ± 0.5%
Flatness - Coplanarity	10~50 µm / 10mm	10~30 µm / 10mm	< 10 µm / 10mm	10~20 µm / 10mm
Tape	Wide selection	Wide selection	Difficult to use Pb-free tape so far	Wide selection
Via/Inner Electrodes	Wide selection	Wide selection	Very difficult in matching shrinkage with hi-Ag to tape	Difficult in matching shrinkage with hi-Ag to tape, but not as well as PLAS
Top Conductors	Need chemical compatibility with tapes	In addition to chemical matching, matching in shrinkage or bowing is needed physically	Need chemical compatibility with tapes	Need chemical compatibility with tapes

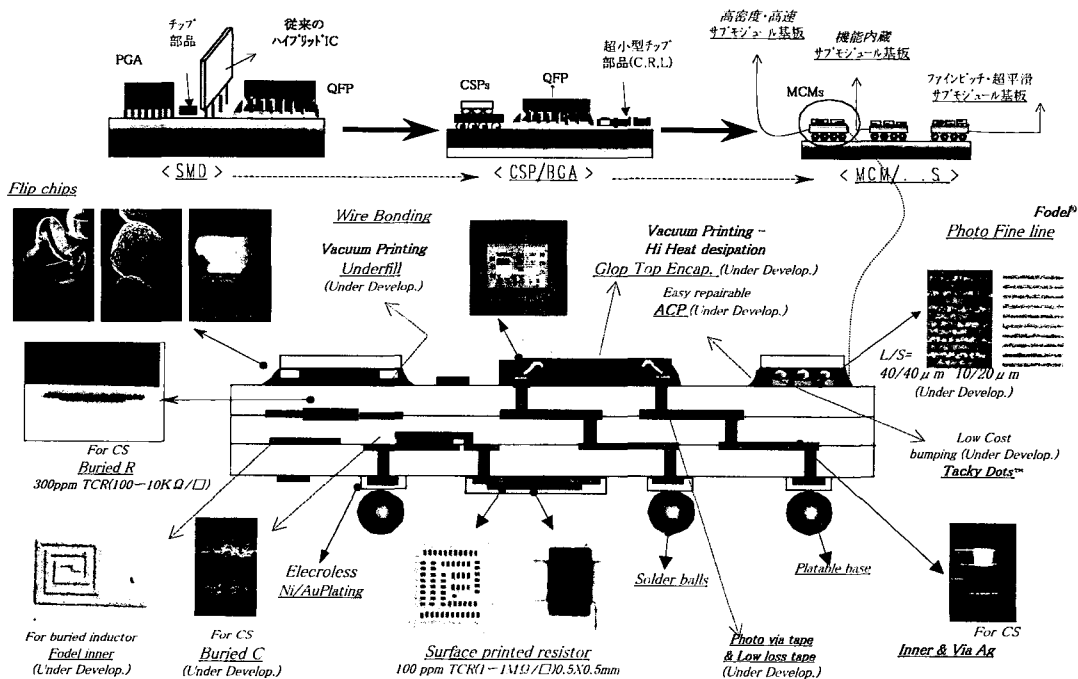
DU PONT

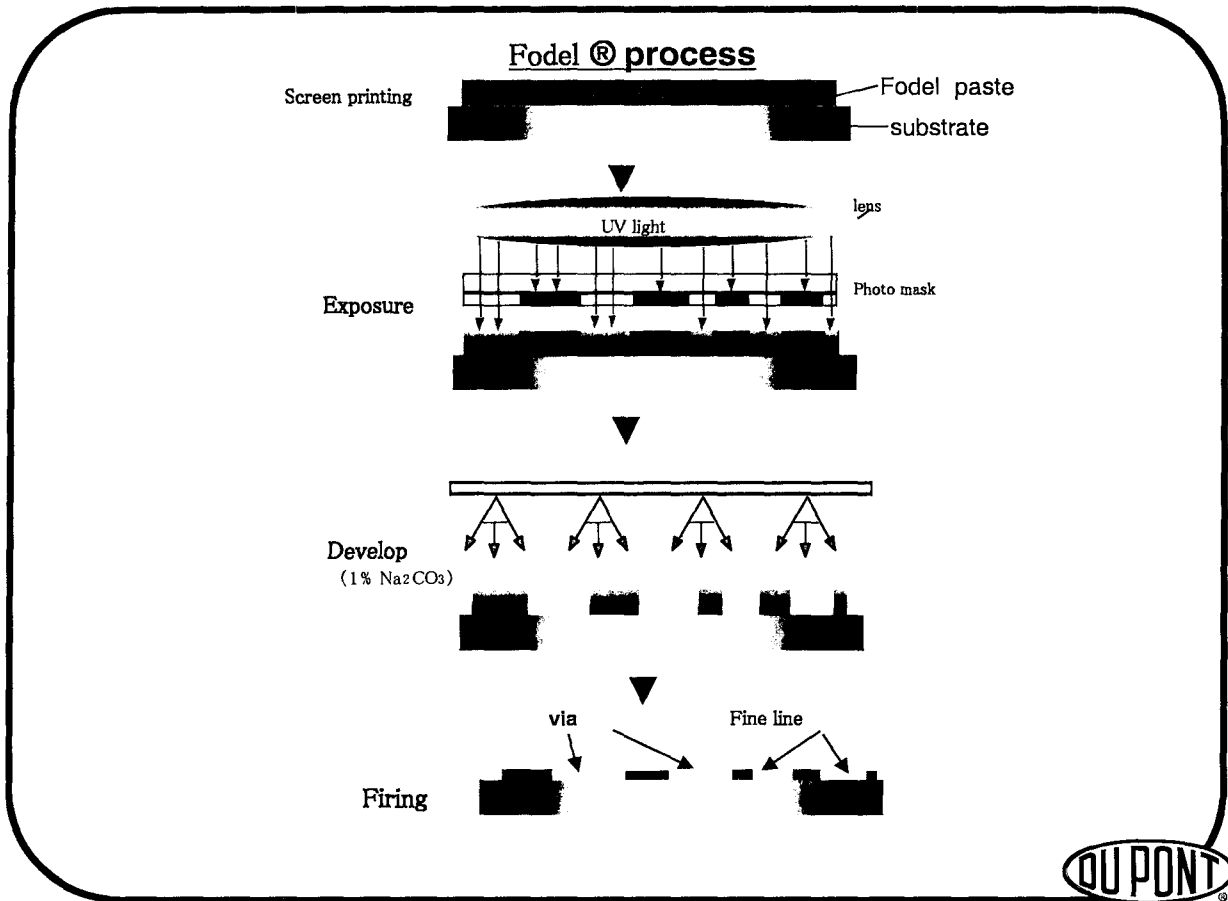
Constrain Sintering LTCC Mfg. Process



Picture provided from MKE

LTCC Portfolio #2





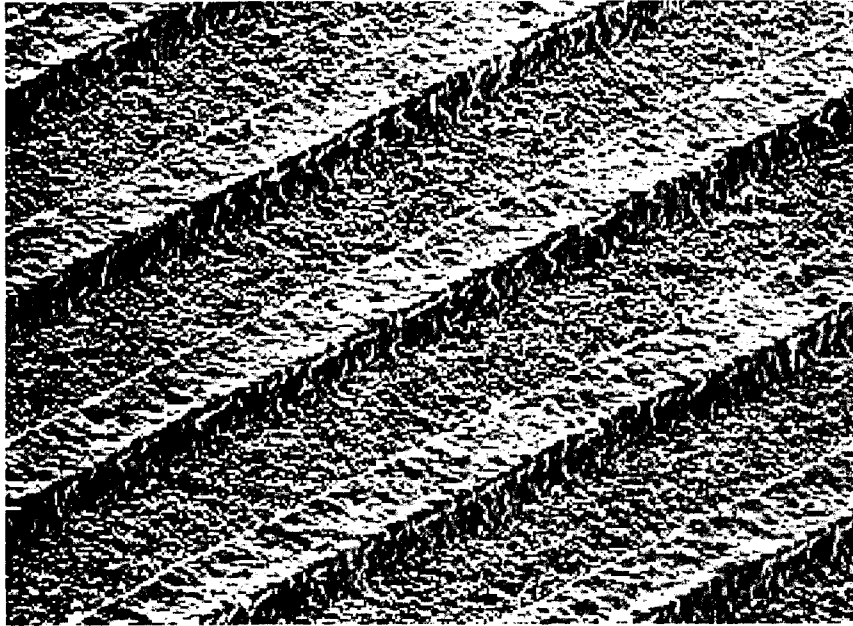
Fodel® Standard Process Pt/Ag Platable Conductor

Process	Recommendation	Remarks
Dry thickness	12 ~ 18 μ m	Screen printing
Leveling	10min	@ Room temperature
Drying	80 °C / 20min	Dry oven
Exposure	600 ~ 1,000mj / cm ²	Hg or Hg/Xe UV Light(λ_{max} : 635nm)
Develop	TTC* X 1.2 ~ 2.0	0.4% Na ₂ CO ₃ (Sodium carbonate)30 °C
Firing	850 °C / 10min(Peak)	Belt furnace

*) TTC: Total Time to Clean



Fodel® Ag/Pt 7090



On Alumina

30 μ m / 30 μ m (Line & Space)



Line Resolution Fodel® vs Screen Printing

Screen Printing

Fodel®

6002F Low Temp. Cu

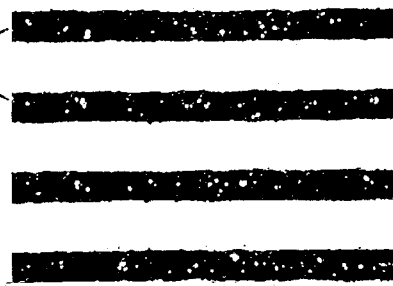
Fodel® Platable Pt/Ag

Top View
Back Light

50 μ m W

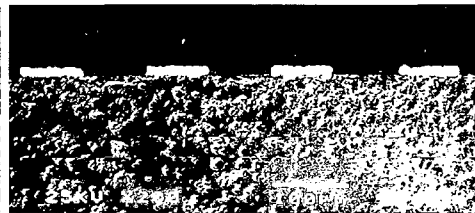
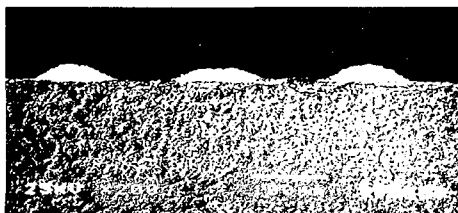


Lines

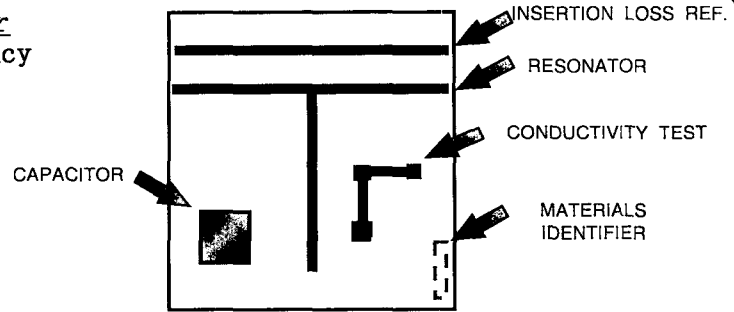


X-Section

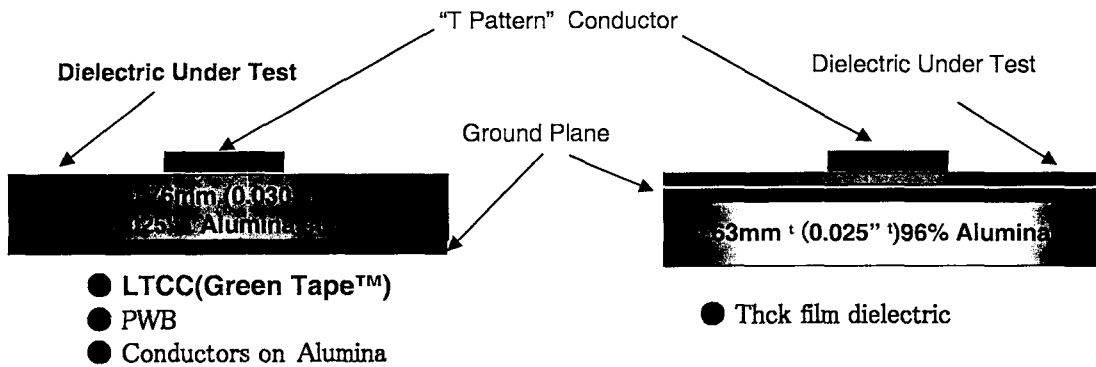
75 μ m W



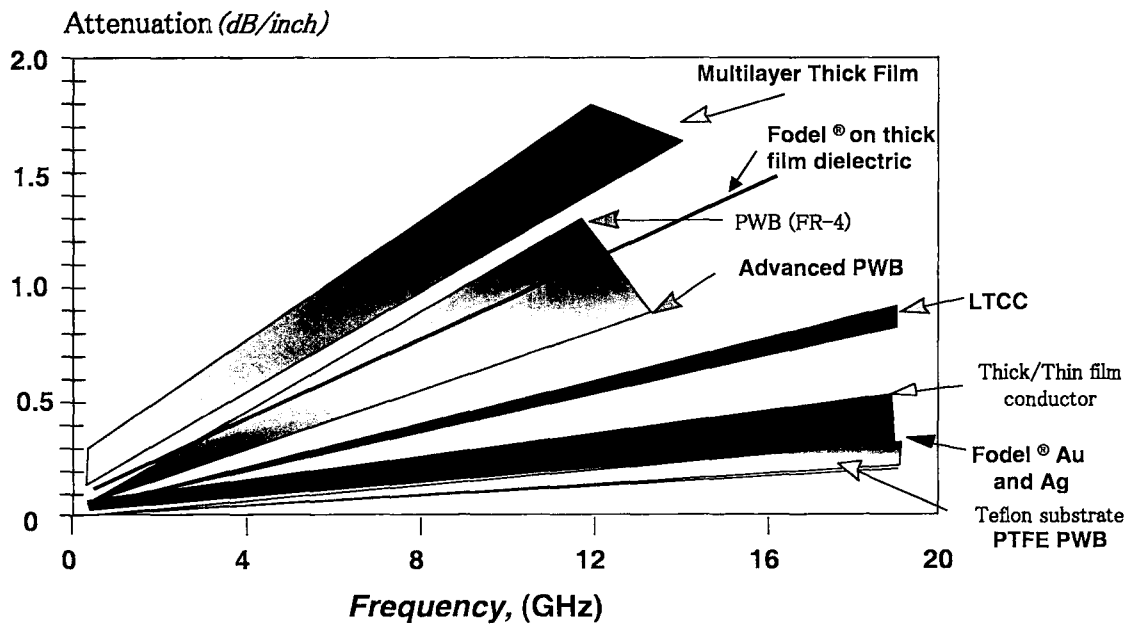
T Pattern Resonator
for high frequency
characterization



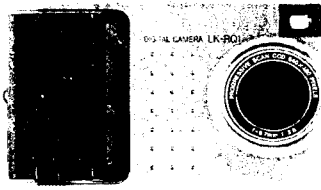
T Pattern Test Sample Construction



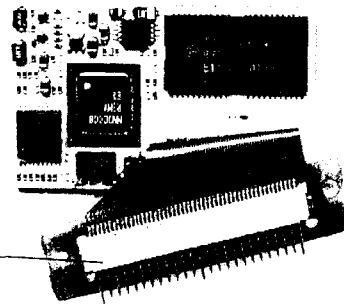
Comparison of high frequency performance
Attenuation-Frequency 50 Ω microstrip line



M K E D S C 2 n d M o d
M a d e u s i n g x L T



Bottom View



CSP on HTCC Interposer

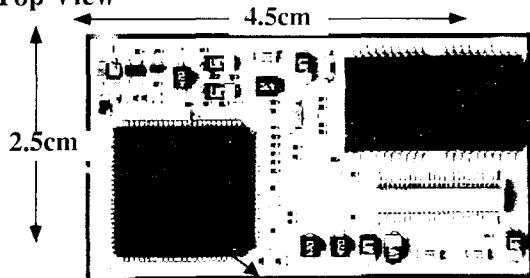
Brad Pitt
Marketing Manager
Microelect. Materials, Asia Pacific



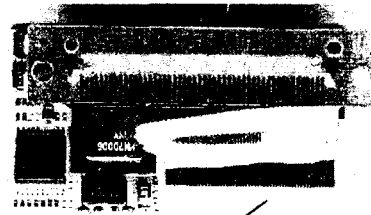
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松下寿電子工業株式会社製カードサイズ・(9.1X6.0cm)デジタルスチールカメラに採用されている10枚11層の無収縮LTCC基板(2.5X4.5cm)が心臓部であるデジタル回路に使われている。両面部品実装でフレキシブル・ケーブル・コネクタを異方性接着材で接合した世界初のセラミック・リジッド・フレックス基板のハイブリッド・モジュールである。またQFP↑下には1005より小さいサイズの抵抗が70個、最上層に印刷されている。

Top View



70 Printed Resistors (0.5 mm X 0.5 mm)
Underneath QFP



C o n n e c t



BLUETOOTH MODULE

